

# IRLB3034PBF-VB Datasheet N-Channel 40-V (D-S) MOSFET

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	40				
$R_{DS(on)}(\Omega)$ at $V_{GS} = 10 \text{ V}$	0.00084				
I <sub>D</sub> (A)	409				
Configuration	Single				
Qg (nC)	250				

## **FEATURES**

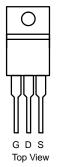
- Trench Power MOSFET
- 100 % R<sub>g</sub> and UIS Tested

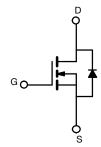
## **APPLICATIONS**

- Synchronous Rectification
- Power Supplies



#### TO-220AB





N-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted)					
PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-source voltage	$V_{DS}$	40	V		
Gate-source voltage		$V_{GS}$	± 20	V	
Continuous drain current <sup>a</sup>	T <sub>C</sub> = 25 °C	1	409		
	T <sub>C</sub> = 125 °C	l <sub>D</sub>	320		
Continuous source current (diode conduction	Is	409	Α		
Pulsed drain current <sup>b</sup>	I <sub>DM</sub>	600			
Single pulse avalanche current	L = 0.1 mH	I <sub>AS</sub>	100		
Single pulse avalanche energy	L = 0.1 mm	E <sub>AS</sub>	500	mJ	
Maximum power dissipation <sup>b</sup>	T <sub>C</sub> = 25 °C	р	375	14/	
	T <sub>C</sub> = 125 °C	$P_{D}$	125	W	
Operating junction and storage temperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	LIMIT	UNIT		
Junction-to-ambient	PCB mount c	$R_{thJA}$	40	°C/W		
Junction-to-case (drain)		$R_{thJC}$	0.4	G/W		

### Notes

- a. Based on T =  $25 \, ^{\circ}$ C.
- b. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- c. When mounted on 1" square PCB (FR4 material)

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PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT	
Static								
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		40	-	-	V	
Gate-source threshold voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$		2.5	3.0	3.5	V	
Gate-source leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$		-	-	± 100	nA	
		V <sub>GS</sub> = 0 V V <sub>DS</sub> = 40 V		-	-	1		
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 40 V, T <sub>J</sub> = 125 °C	-	-	50	μA	
		V <sub>GS</sub> = 0 V	V <sub>DS</sub> = 40 V, T <sub>J</sub> = 175 °C	-	-	300	μA	
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>GS</sub> = 10 V	$V_{DS} \ge 5 V$	100	-	-	Α	
		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 35 A	-	0.00084	-	1	
Drain-source on-state resistance a	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 35 A, T <sub>J</sub> = 125 °C	-	0.00140	-	Ω	
		V <sub>GS</sub> = 10 V	I <sub>D</sub> = 35 A, T <sub>J</sub> = 175 °C	-	0.00164	-		
Forward transconductance b	9 <sub>fs</sub>	$V_{DS}$	= 15 V, I <sub>D</sub> = 30 A	-	196	-	S	
Dynamic <sup>b</sup>							•	
Input capacitance	C <sub>iss</sub>			-	11 938	15 525		
Output capacitance	C <sub>oss</sub>	$V_{GS} = 0 V$	V <sub>DS</sub> = 25 V, f = 1 MHz	-	11 163	14 520	pF	
Reverse transfer capacitance	C <sub>rss</sub>			-	282	370		
Total gate charge <sup>c</sup>	Qg			-	158	250		
Gate-source charge c	Q <sub>gs</sub>	V <sub>GS</sub> = 10 V	$V_{GS} = 10 \text{ V}$ $V_{DS} = 20 \text{ V}, I_D = 100 \text{ A}$		44	-	nC	
Gate-drain charge <sup>c</sup>	Q <sub>gd</sub>	]		-	22	-		
Gate resistance	R <sub>g</sub>	f = 1 MHz		2.70	5.44	8.20	Ω	
Turn-on delay time c	t <sub>d(on)</sub>			-	16	25		
Rise time <sup>c</sup>	t <sub>r</sub>	$V_{DD} = 20 \text{ V}, \text{ R}_{L} = 0.2 \Omega$ $I_{D} \cong 100 \text{ A}, \text{ V}_{GEN} = 10 \text{ V}, \text{ R}_{g} = 1 \Omega$		-	10	17		
Turn-off delay time <sup>c</sup>	t <sub>d(off)</sub>			-	103	160	- ns -	
Fall time <sup>c</sup>	t <sub>f</sub>			-	61	95		
Source-Drain Diode Ratings and Chara	cteristics b							
Pulsed current <sup>a</sup>	I <sub>SM</sub>			-	-	260	Α	
Forward voltage	$V_{SD}$	I <sub>F</sub> = 60 A, V <sub>GS</sub> = 0 V		-	0.81	1.5	V	
Body diode reverse recovery time	t <sub>rr</sub>	l <sub>F</sub> = 30 A, di/dt = 100 A/μs		-	165	350	ns	
Body diode reverse recovery charge	Q <sub>rr</sub>			-	530	1100	nC	
Reverse recovery fall time	ta			-	66	-		
Reverse recovery rise time	t <sub>b</sub>	1		-	99	-	ns	
Body diode peak reverse recovery current	I <sub>RM(REC)</sub>			_	-6.2	-	Α	

#### Notes

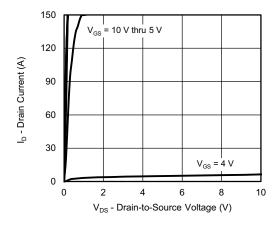
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing
- c. Independent of operating temperature

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

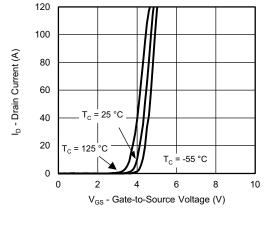
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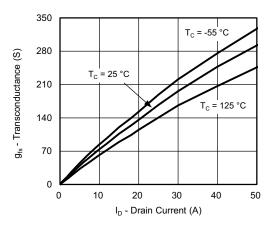
## **TYPICAL CHARACTERISTICS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



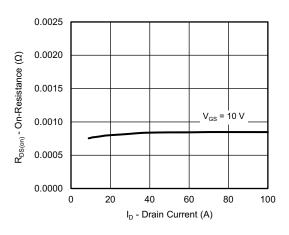
#### **Output Characteristics**



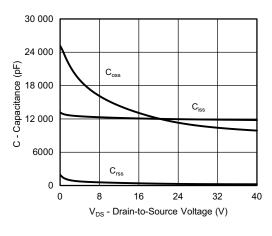
**Transfer Characteristics** 



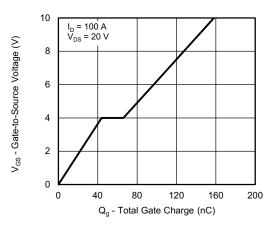
Transconductance



On-Resistance vs. Drain Current



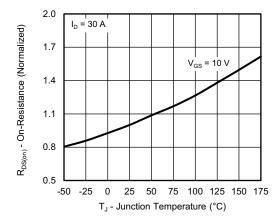
Capacitance



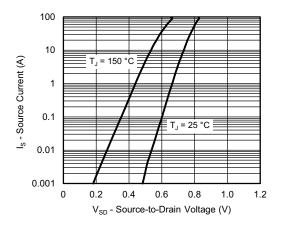
**Gate Charge** 



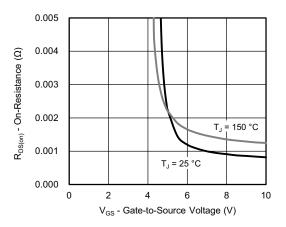
## **TYPICAL CHARACTERISTICS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



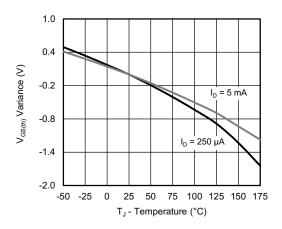
On-Resistance vs. Junction Temperature



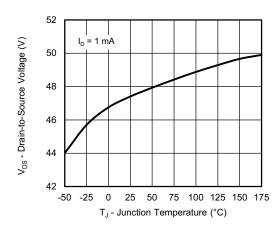
**Source Drain Diode Forward Voltage** 



On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage

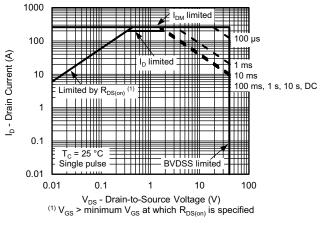


**Drain Source Breakdown vs. Junction Temperature** 

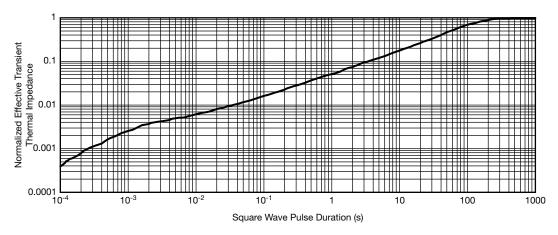
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## **THERMAL RATINGS** ( $T_A = 25$ °C, unless otherwise noted)



Safe Operating Area



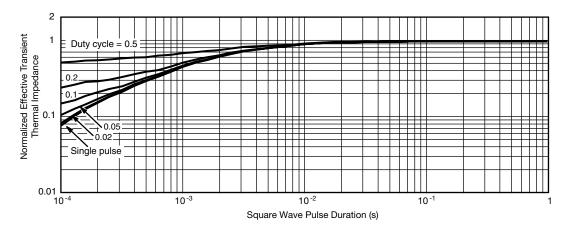
Normalized Thermal Transient Impedance, Junction-to-Ambient

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## **THERMAL RATINGS** (T<sub>A</sub> = 25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

#### Note

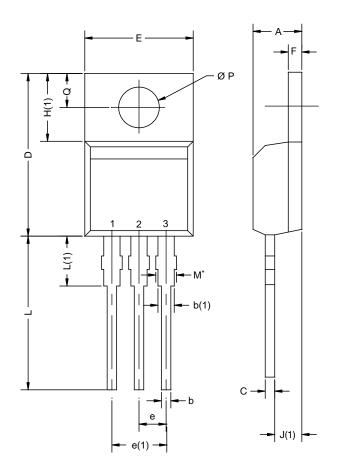
- The characteristics shown in the two graphs
  - Normalized Transient Thermal Impedance Junction-to-Ambient (25 °C)
  - Normalized Transient Thermal Impedance Junction-to-Case (25 °C)

are given for general guidelines only to enable the user to get a "ball park" indication of part capabilities. The data are extracted from single pulse transient thermal impedance characteristics which are developed from empirical measurements. The latter is valid for the part mounted on printed circuit board - FR4, size 1" x 1" x 0.062", double sided with 2 oz. copper, 100 % on both sides. The part capabilities can widely vary depending on actual application parameters and operating conditions

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## **TO-220AB**



	MILLIN	IETERS	INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	4.25	4.65	0.167	0.183	
b	0.69	1.01	0.027	0.040	
b(1)	1.20	1.73	0.047	0.068	
С	0.36	0.61	0.014	0.024	
D	14.85	15.49	0.585	0.610	
E	10.04	10.51	0.395	0.414	
е	2.41	2.67	0.095	0.105	
e(1)	4.88	5.28	0.192	0.208	
F	1.14	1.40	0.045	0.055	
H(1)	6.09	6.48	0.240	0.255	
J(1)	2.41	2.92	0.095	0.115	
L	13.35	14.02	0.526	0.552	
L(1)	3.32	3.82	0.131	0.150	
ØР	3.54	3.94	0.139	0.155	
Q	2.60	3.00	0.102	0.118	
ECN: X12-0208-Rev. N, 08-Oct-12 DWG: 5471					

### Notes

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 $<sup>^{\</sup>star}$  M = 1.32 mm to 1.62 mm (dimension including protrusion) Heatsink hole for HVM



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